Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/934,004	LI ET AL.	
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED						
Class	Subclass	Date	Examiner			
715	725	6/27/2006	LVN			
			-			
	 					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
715	<i>1</i> 725	6/27/2006		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
US-PGPUB, USPAT: 715/723-726, 346/225,236, 348/700	6/27/2006	LVN		
consulted w/Ba Huynh	6/27/2006	LVN		
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